## Notice of References Cited Application/Control No. 10/067,350 Examiner Ba Huynh Applicant(s)/Patent Under Reexamination FUJII ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,272,397	09-2007	Gallagher et al.	455/436
*	В	US-7,251,827	07-2007	Guo et al.	726/8
*	С	US-7,010,582	03-2006	Cheng et al.	709/219
*	D	US-7,003,481	02-2006	Banka et al.	705/26
*	E	US-2002/0048268	04-2002	Menon et al.	370/349
*	F	US-2002/0007452	01-2002	TRAW et al.	713/152
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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